

SEMITRANS™ 3

Low Loss IGBT Modules

SKM 400GB124D

SKM 400GAL124D

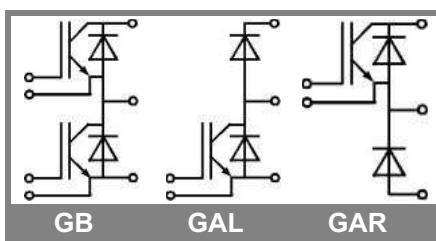
SKM 400GAR124D

Features

- MOS input (voltage controlled)
- N channel, homogeneous Si-structure (NPT- Non punch-through IGBT)
- Low inductance case
- Very low tail current with low temperature dependence
- High short circuit capability, self limiting to $6 \times I_{CNOm}$
- Latch-up free
- Fast & soft inverse CAL Diodes
- Isolated copper baseplate using DCB Direct Copper Bonding Technology without hard mould
- Large clearance (12 mm) and creepage distance (20 mm)

Typical Applications

- Switching (not for lineal use)
- Inverter drives
- UPS



Absolute Maximum Ratings		$T_c = 25^\circ\text{C}$, unless otherwise specified		
Symbol	Conditions	Values		Units
IGBT				
V_{CES}		1200		V
I_c	$T_c = 25 (80)^\circ\text{C}$	570 (400)		A
I_{CRM}	$t_p = 1 \text{ ms}$	600		A
V_{GES}		± 20		V
$T_{vj} (T_{stg})$	$T_{OPERATION} \leq T_{stg}$	- 40 ... + 150 (125)		°C
V_{isol}	AC, 1 min.	2500		V
Inverse diode				
I_F	$T_c = 25 (80)^\circ\text{C}$	390 (260)		A
I_{FRM}	$t_p = 1 \text{ ms}$	600		A
I_{FSM}	$t_p = 10 \text{ ms}; \sin.; T_j = 150^\circ\text{C}$	2900		A
Freewheeling diode				
I_F	$T_c = 25 (80)^\circ\text{C}$	390 (260)		A
I_{FRM}	$t_p = 1 \text{ ms}$	600		A
I_{FSM}	$t_p = 10 \text{ ms}; \sin.; T_j = 150^\circ\text{C}$	2900		A

Characteristics		$T_c = 25^\circ\text{C}$, unless otherwise specified		
Symbol	Conditions	min.	typ.	max.
IGBT				
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_c = 12 \text{ mA}$	4,5	5,5	6,5
I_{CES}	$V_{GE} = 0, V_{CE} = V_{CES}, T_j = 25 (125)^\circ\text{C}$	0,2	0,6	mA
$V_{CE(TO)}$	$T_j = 25 (125)^\circ\text{C}$	1,1 (1,1)	1,25 (1,25)	V
r_{CE}	$V_{GE} = 15 \text{ V}, T_j = 25 (125)^\circ\text{C}$	3,3 (4,3)	4 (5,3)	mΩ
$V_{CE(sat)}$	$I_{Cnom} = 300 \text{ A}, V_{GE} = 15 \text{ V}$, chip level	2,1 (2,4)	2,45 (2,85)	V
C_{ies}	under following conditions	22	30	nF
C_{oes}	$V_{GE} = 0, V_{CE} = 25 \text{ V}, f = 1 \text{ MHz}$	3,3	4	nF
C_{res}		1,2	1,6	nF
L_{CE}			20	nH
$R_{CC' + EE'}$	res., terminal-chip $T_c = 25 (125)^\circ\text{C}$	0,35 (0,5)		mΩ
$t_{d(on)}$	$V_{CC} = 600 \text{ V}, I_{Cnom} = 300 \text{ A}$	85		ns
t_r	$R_{Gon} = R_{Goff} = 5 \Omega, T_j = 125^\circ\text{C}$	65		ns
$t_{d(off)}$	$V_{GE} = \pm 15 \text{ V}$	680		ns
t_f		56		ns
$E_{on} (E_{off})$		36 (42)		mJ
Inverse diode				
$V_F = V_{EC}$	$I_{Fnom} = 300 \text{ A}; V_{GE} = 0 \text{ V}; T_j = 25 (125)^\circ\text{C}$	2 (1,8)	2,5	V
$V_{(TO)}$	$T_j = (125)^\circ\text{C}$	(1,1)	(1,2)	V
r_T	$T_j = (125)^\circ\text{C}$		(3,5)	mΩ
I_{RRM}	$I_{Fnom} = 300 \text{ A}; T_j = (125)^\circ\text{C}$	(136)		A
Q_{rr}	di/dt = A/μs	36		μC
E_{rr}	$V_{GE} = V$			mJ
FWD				
$V_F = V_{EC}$	$I_F = 300 \text{ A}; V_{GE} = 0 \text{ V}, T_j = 25 (125)^\circ\text{C}$	2 (1,8)	2,5	V
$V_{(TO)}$	$T_j = (125)^\circ\text{C}$	(1,1)	(1,2)	V
r_T	$T_j = (125)^\circ\text{C}$		(3,5)	mΩ
I_{RRM}	$I_F = 300 \text{ A}; T_j = (125)^\circ\text{C}$	(136)		A
Q_{rr}	di/dt = A/μs	36		μC
E_{rr}	$V_{GE} = V$			mJ
Thermal characteristics				
$R_{th(j-c)}$	per IGBT		0,05	K/W
$R_{th(j-c)D}$	per Inverse Diode		0,125	K/W
$R_{th(j-c)FD}$	per FWD		0,125	K/W
$R_{th(c-s)}$	per module		0,038	K/W
Mechanical data				
M_s	to heatsink M6	3	5	Nm
M_t	to terminals M6	2,5	5	Nm
w			325	g

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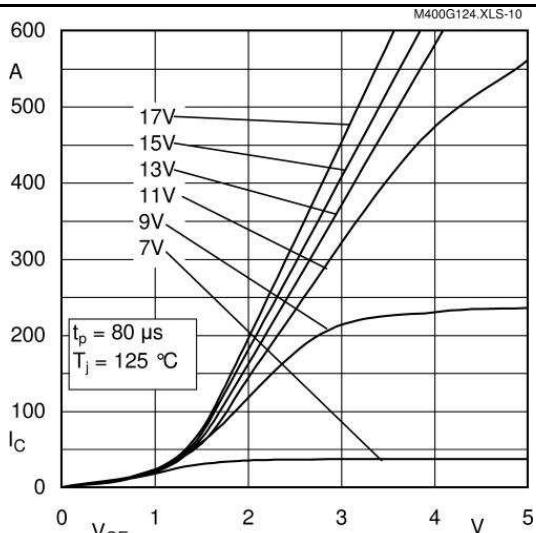


Fig. 1 Typ. output characteristic, inclusive $R_{CC} + EE'$

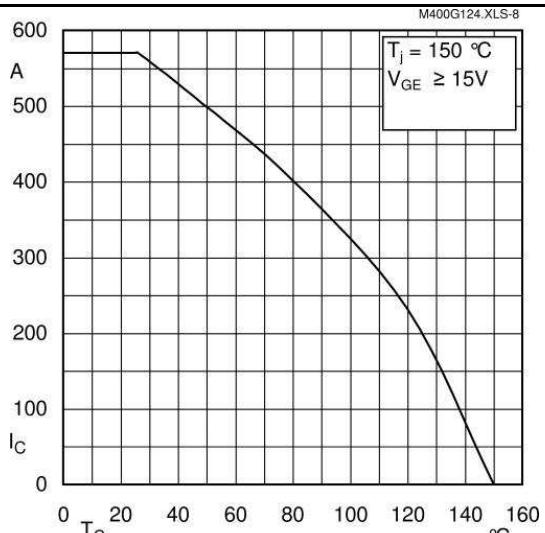


Fig. 2 Rated current vs. temperature $I_C = f(T_C)$

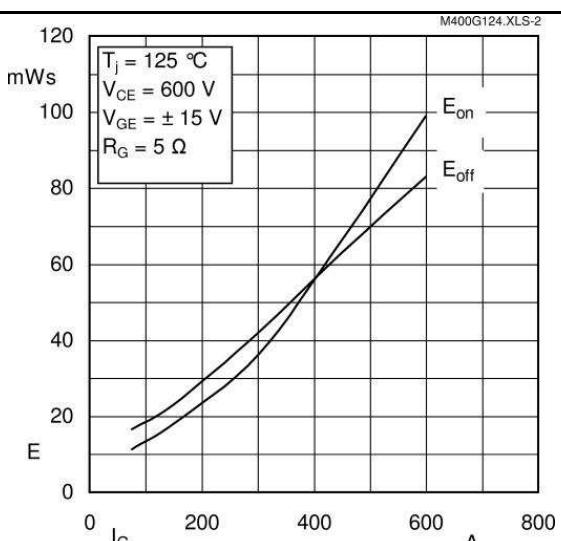


Fig. 3 Typ. turn-on / off energy = $f(I_C)$

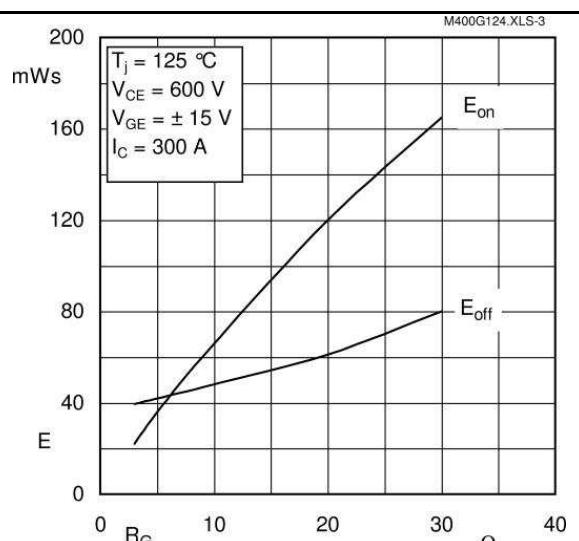


Fig. 4 Typ. turn-on / off energy = $f(R_G)$

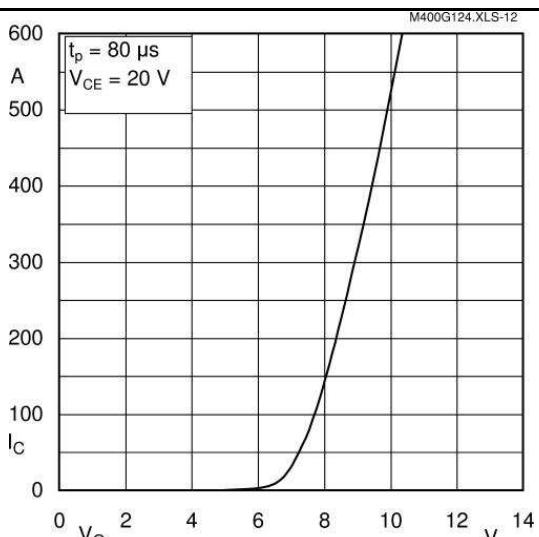


Fig. 5 Typ. transfer characteristic

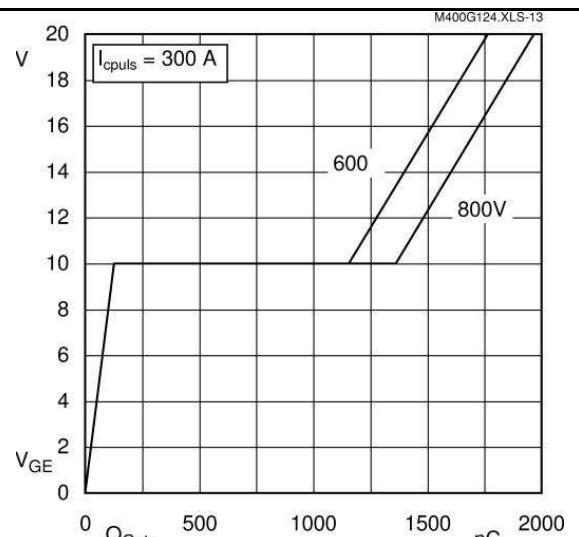


Fig. 6 Typ. gate charge characteristic

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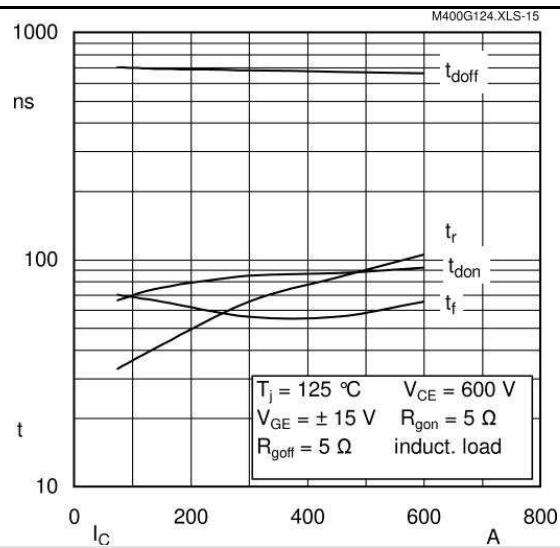


Fig. 7 Typ. switching times vs. I_C

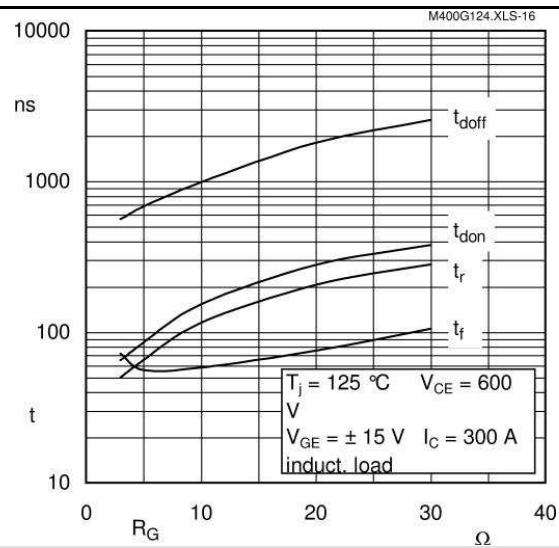


Fig. 8 Typ. switching times vs. gate resistor R_G

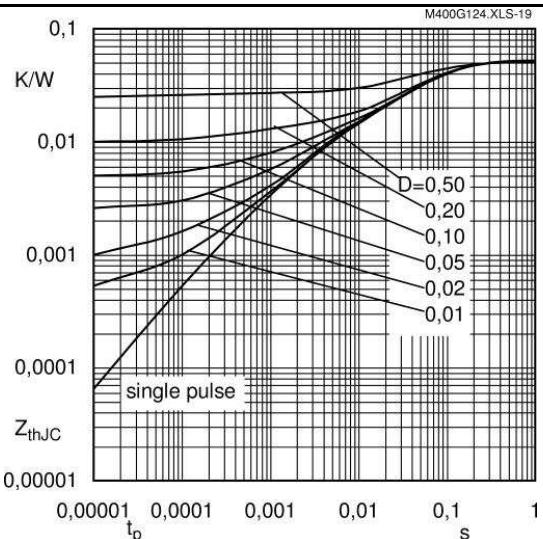


Fig. 9 Transient thermal impedance of IGBT

$$Z_{thp(j-c)} = f(t_p); D = t_p/t_c = t_p * f$$

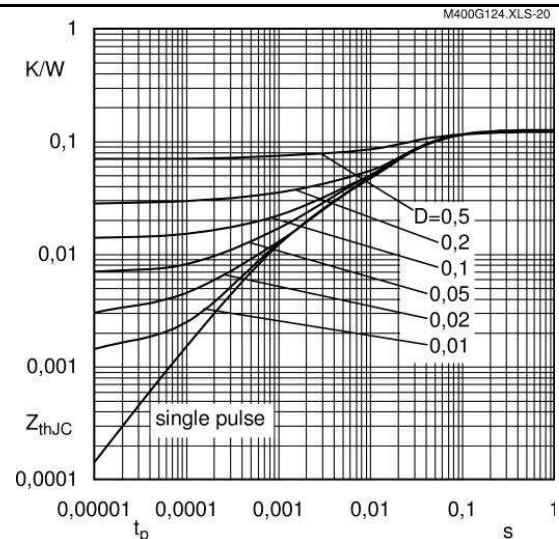


Fig. 10 Transient thermal impedance of FWD

$$Z_{thp(j-c)} = f(t_p); D = t_p/t_c = t_p * f$$

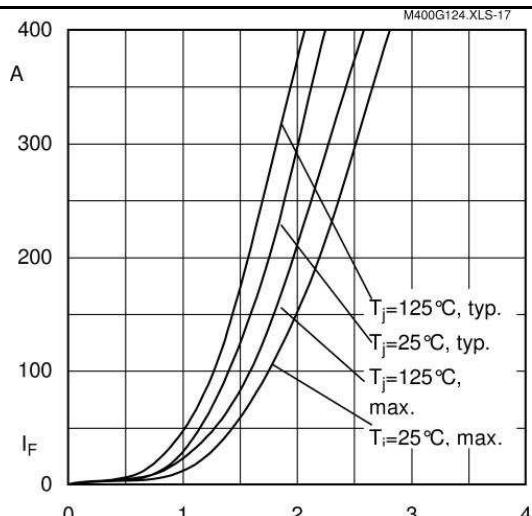


Fig. 11 CAL diode forward characteristic

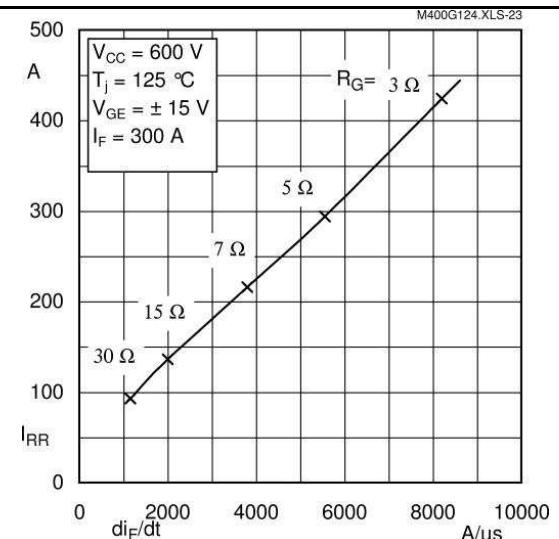


Fig. 12 Typ. CAL diode peak reverse recovery current

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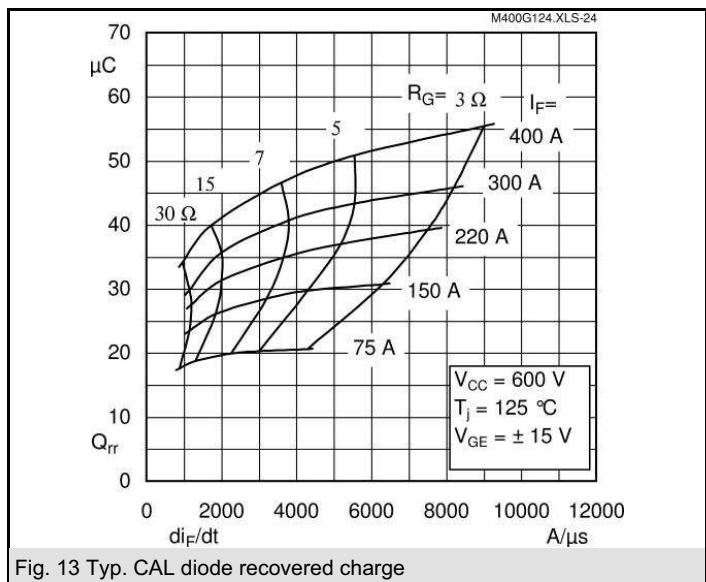
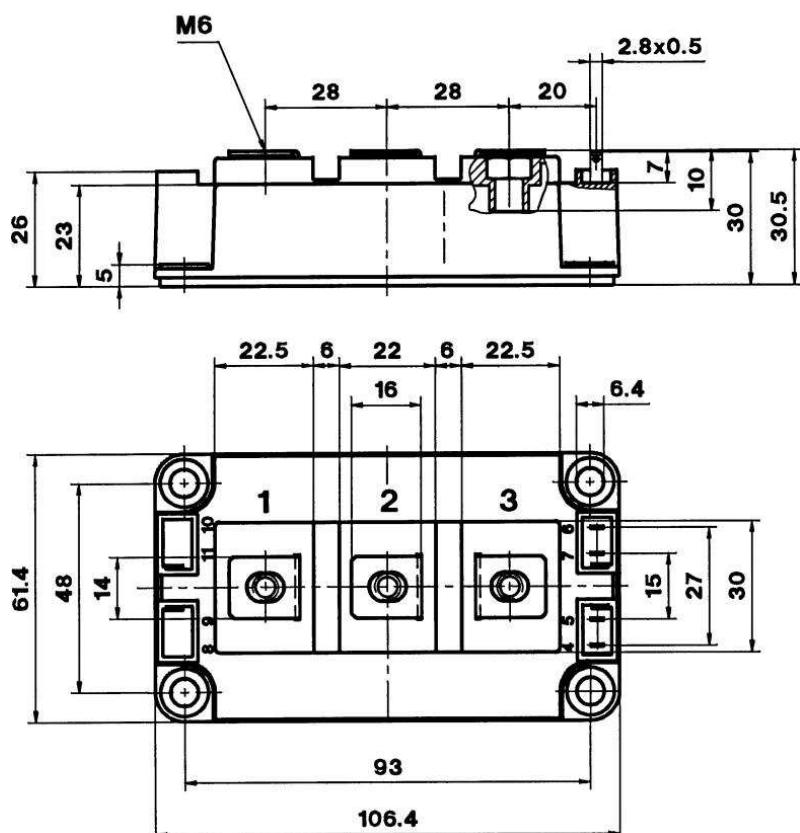


Fig. 13 Typ. CAL diode recovered charge

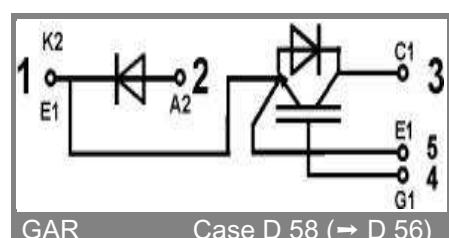
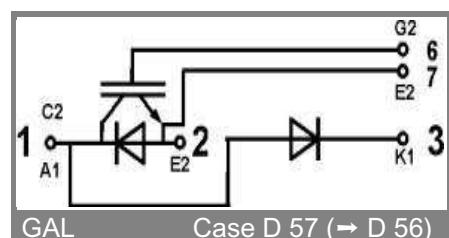
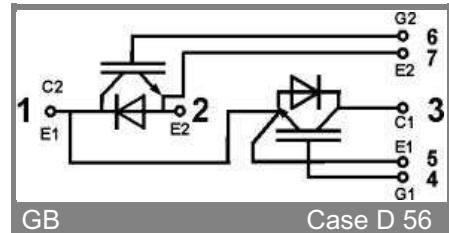
UL Recognized
File no. E 63 532

Dimensions in mm

CASED56



Case D 56



This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

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